Search Notes



Application No.	Applicant(s)	
09/870,332	SHEPARD ET AL.	
Examiner	Art Unit	
Sean E Vincent	1731	

SEARCHED					
Class	Subclass	Date	Examiner		
65	29.11	7/18/2003	sv		
	29.18				
	29.19				
	114				
	115				
	158				
	161				
	162				
	DIG 13				
356	43	7/22/2003	sv		
374	9	7/22/2003	sv		
	120				

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
	<u> </u>				

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
IEEE Xplore keywords: pyrometer, lumines(stem), photolumines(stem), temperature, emission and laser	7/23/2003	SV	
-			